

HumiChip®

Humidity & Temperature Solution

Features

- Fully Calibrated & Temperature Compensated
- Digital or Analog Output with Alarm Function
- Precision & Accuracy (±2%RH, ±0.3°C, 14 bit)
- Free Operating Voltage (min 2.3V to max 5.5V)
- Low Current Consumption
- SMD Package for Automated Assembly
- Reliable in Harsh Environment



Product Summary

HumiChip[®] offers the most advanced and cost effective humidity and temperature sensing solution for virtually any type of applications.

Capacitive polymer sensor chip developed and fabricated in-house and CMOS integrated circuit with EEPROM are integrated into one embedded system in a reflow solder-able SMD package.

Individually calibrated and tested, **HumiChip**® performs ±2% from 20% to 80%RH (±3% over entire humidity range), and yet, is simple and ready to use without further calibration or temperature compensation.

HumiChip® provides linear output signals in various interfaces to customer requirements - the standard I²C interface, PDM convertible to analog signal, and an Alarm function for preset control at min/max humidity.

Designed and manufactured by industry leading humidity and temperature sensing technology of **SAMYOUNG S&C** – field proven in HVAC and Auto industry for over 10 years, **HumiChip**[®] offers another sensible sensing solution for excellent reliability, high accuracy, and cost effective sensing applications.

Application

Energy Saving HVAC Control

Air Conditioning, Refrigeration, IAQ monitoring, Vent Fans, Home Appliances, Humi/Dehumidifiers

Process Control & Instrumentations

Medical Instruments, Handheld Devices, Weather Stations, Food Processing, Printers, RFIDs ...

Automobile & Transportation

Cabin Climate Control, Defogging Control Condensing Preventive Devise ...,

Mass Quantity Application

OEM custom specification available



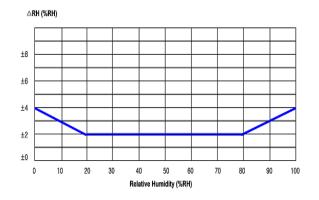
Sensor Performance

Relative Humidity (RH%)

* Custom Accuracy Tolerance Available

Resolution	14 bit (0.01%RH)
Accuracy ¹	±2.0 %RH (20~80%RH)*
Repeatability	±0.2 %RH
Hysteresis	±2.0 %RH
Linearity	<2.0 %RH
Response time ²	7.0 sec (τ 63%)
Tomp Coofficient	Min 0.05 %RH/℃
Temp Coefficient	(at 10~60℃, 10~90%RH)
Operating range	0 ~ 100 %RH (Non-Condensing)
Long term drift	<0.5 %RH/yr (Normal condition)

Figure 1. Typical RH% Accuracy at 25 °C

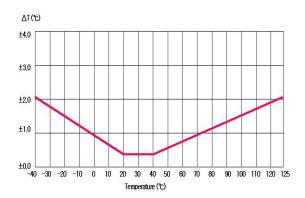


Temperature (°C)

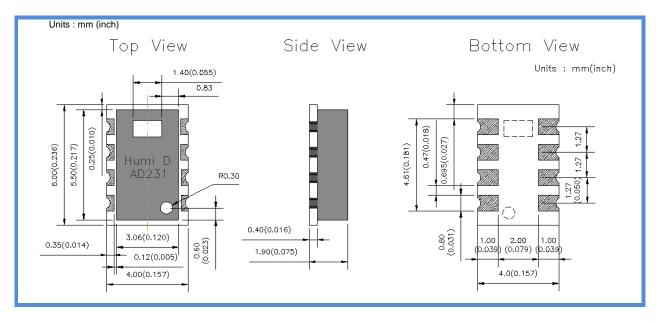
Resolution	14 bit (0.01℃)
Accuracy ³	±0.3 °C (Figure 2)
Repeatability	± 0 .1 ℃
Response time4	5.0 sec (τ 63%)
Operating range	- 40 ~ 125 °C
Long term drift	<0.05 °C/yr (Normal condition)

- 1. Accuracies measured at 25 °C, 5.0V.
- 2. Measured at 25 $^{\circ}$ C, 1m/sec airflow for achieving 63% of step from 33%RH to 90%RH
- 3. Accuracies measured at 25 $^{\circ}$ C, 5.0V.
- 4. Min 5.0 sec, Max 20 sec

Figure 2. Typical Temperature Accuracy



Dimensions





Electrical Specification

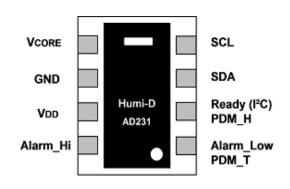
Supply Voltage ^{*1}	min 2.3V ~ max 5.5V
Supply Current (IDD)	750 µA (typical)
Sleep Current (Isleep)*2	0.6 μA (typical)

Environmental

Operating Temperature	- 40 ~ 125℃	
Operating Humidity	0~100%RH	
Operating Humbily	(non condensing)	

^{*1.} Lower than 2.7V supply voltage may increase the accuracy tolerance of the Temperature.

Pin Connection



Absolute Maximum Rating

Parameter	Min	Max
Supply Voltage (VDD)	-0.3V	6.0V
Storage Temp	-55 ℃	150 ℃
Junction Temp	-55 ℃	1 50 ℃

Soldering Information

Standard or IR Solder Reflow. Tp: 260°C, tp: 40 sec. (qualify Pb free profile)

Package Contents

Capacitive polymer RH Sensor, PTA (Proportional to Absolute) Temperature sensor integrated ASIC chip in LCC (Leadless Chip Carrier) package, SMD.

RoHS Compliant

Shipping

Reel & Tape: 2,500 / 500 ea

Ordering Information

О	utput	Accuracy	VDD	MODE	Ordering P/N
	±2%RH	3.3	l la data	HCPD- 3V-U2	
D	I ² C	±3%RH	5.0	Update	HCPD- 5V-U3
٦	ן מ	±2%RH	3.3	Sleep	HCPD- 3V-S2
			±3%RH	5.0	Sieep
Α	A PDM	±2%RH	3.3	lladoto	HCPA- 3V-U2
A PDIVI	±3%RH	5.0	Update	HCPA- 5V-U3	

◆ For more detail Part Numbers, Please refer to the Table 7-1

Standard Digital (I²C) Output:

Factory setting is **Sleep Mode** and calibrated at **3.3V.**

Humidity, Temperature, and 2 Alarm (Hi / Low) functions for relative humidity.

> Standard Analog (PDM) Output:

Update Mode is calibrated at 5.0V.

Humidity, Temperature, and an Alarm (high) function.

^{*2.} at -40 ~ 85°C



Application Guide

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☞ Demo Kit (EVB01-HCP) is available.

A reference program source code can be downloaded from www.samyoungsnc.com



1. General Information

1.1 Preliminary Consideration

To maximize the performance of **HumiChip**[®], it is important to plan an appropriate location of the sensor at the design stage. Airflow and proper exposure to ambient air must be secured for **HumiChip**[®] to ensure expected performance. Airflow holes must NOT be blocked. Any heat

generating parts near **HumiChip**® will distort the proper measurement of relative humidity and temperature reading, and either should be avoided or measures should be taken to prevent heat transfer.

1.2 Operating Conditions

HumiChip[®]'s maximum and recommended normal operating condition is shown below (**Figure 1.1**). Within the Normal Range **HumiChip**[®] performs stable. Prolonged exposures to conditions outside normal range, especially at humidity over 90%RH, may temporarily offset the RH signal up to ±3%RH. When return to Normal Range, it will gradually recover back to the calibration state.

Re-Conditioning Procedure in **section 1.6** will help reduce this recovery time. Long term exposure to extreme conditions may also accelerate aging of the sensor.

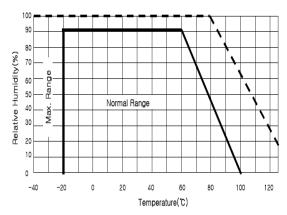


Figure 1.1 Operating Conditions

1.3 Heating

Though within the accuracy tolerance, Self-Heating in the sensor IC may affect accurate measurement of temperature and RH%. The measurement error from Self Heating can be reduced by keeping 'Active State' to the minimum, and by regulating the operating voltage within 3.3±0.5V or 5.0±0.5V. In order to minimize the self heating, sampling time should be more than 180ms. (200ms

recommended)

Other heat sources such as power electronics, microcontrollers, and display near the sensor may affect the accurate measurement. The location of Sensor near such heat sources should be avoided by maintaining distance or thermal buffer. Thin metal pattern, or even better, 'milling slits' around the sensor also may help reduce the error.

1.4 Soldering Instruction

HumiChip® is designed for mass production reflow soldering process. It is qualified for soldering profile according to IPC/JEDEC J-STD-020D (see <u>Figure 1.2</u>) for Pb-free assembly in standard reflow soldering ovens or IR/Convection reflow ovens to withstand peak temperature at 240 °C and peak time up to 40 sec. For soldering in Vapor Phase Reflow (VPR) ovens the peak conditions are limited to $T_P < 240$ °C with $t_P < 40$ sec and ramp-up/down speeds shall be limited to 10 °C/sec. For manual soldering, contact time should not exceed 4 seconds at up to 350 °C. No-Clean solder flux should be used.

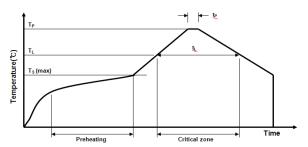


Figure 1.2 Soldering Profile IPC/JEDEC standard $T_P \le 240\,^{\circ}C$, $t_P < 40 \text{sec}$, $T_L < 200\,^{\circ}C$, $t_L < 150 \text{sec}$. Ramp-up/down speed $< 5\,^{\circ}C$ /sec.



Note: Test or measurement right after reflow soldering may read an offset as the sensor needs time for stabilization from the soldering heat. The recovery time may vary depending on reflow soldering profile and ambient storage condition.

For most of the standard reflow soldering profile, allow 12 hours of stabilization under room environment (23±3°C, 55±5%RH).

Contact our **customer support** for the optimal reflow profile recommended and the customized recovery measures specific to your reflow soldering process. [support@samyoungsnc.com]

For **Land Pattern** drawing & dimensions, see **Drawing 1** on page 9.

1.5 Storage and Handling Information

HumiChip® contains polymer based capacitive humidity sensor sensitive to environment, and should NOT be handled as an ordinary electronic component.

Chemical vapors at high concentration may interface with the polymer layers, and coupled with long exposure time, may cause a shift in both offset and sensitivity of the sensor.

Despite the sensor endures the extreme conditions of -55° C \sim 150°C, 0% \sim 100%RH (non condensing), long term exposure in such environment may also

offset the sensor reading. Hence, once the package is opened, it is recommended to store in clean environment of temperature at $5^{\circ}\text{C} \sim 55^{\circ}\text{C}$ and humidity at $10\% \sim 70\%$ RH.

HumiChip® is protected of ESD up to 4000V and Latchup of ±100mA or (up to +8V / down to -4V) relative to VSS/VSSA, and also packed in ESD protected shipping material. Normal ESD precaution is required when handling in assembly process.

1.6 Reconditioning Procedure

If **HumiChip**[®] is exposed or contaminated with chemical vapors, the following reconditioning procedure will recover the sensor back to calibration state.

Baking: 120℃ for 6 hrs and

Re-Hydration: 30°C at > 80%RH for 24 hrs

1.7 Material Contents

HumiChip® consists of sensor cell and IC (polymer / glass & silicon substrate) packaged in a surface mountable LCC (Leadless Chip Carrier) type package. The sensor housing consists of a PPS (Poly Phenylene Sulfide) cap with epoxy glob top on

a standard FR4 substrate. Pads are made of Au plated Cu. The device is free of Pb, Cd and Hg.

RoHS compliant / REACH report available

1.8 Traceability Information

HumiChip® is laser marked with product type and lot identification.

Further information about individual sensor is electronically stored on the chip.

The first line denotes the sensor type: HUMI-A for PDM output, HUMI-D for I^2C output.

Lot identification is printed on the second line with 5 digit alphanumeric code.

An electronic identification code stored on the chip can be decoded by **Samyoung S&C** only and allows for tracking on batch level through production, calibration and testing.

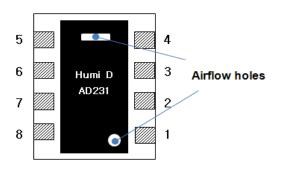




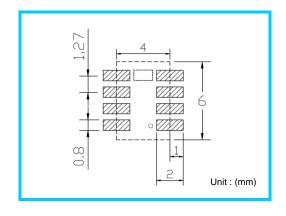
Figure 1.3 Laser Marking

1.9 Shipping Package

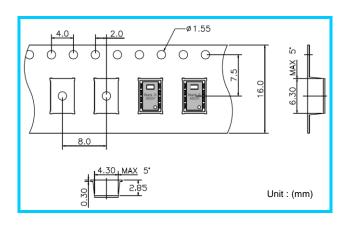
HumiChip® is provided in a tape & reel shipment packaging, sealed into antistatic ESD trays. Standard packaging sizes are 2,500 or 500 units per

reel. The drawing of the packaging tapes with sensor orientation and packing box dimensions are shown in **Drawing 2** and **Drawing 3** below.

Drawing 1 Land Pattern



Drawing 2 Packing Reel & Tape

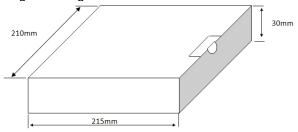


Drawing 3 Packing (Box)

Inbox: 500ea

Dimension: 215 x 210 x 30 mm

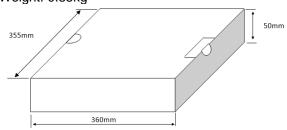
Weight: 0.25kg



Inbox: 2,500ea

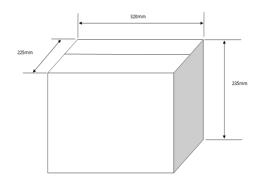
Dimension: 360 x 355 x 50 mm

Weight: 0.85kg



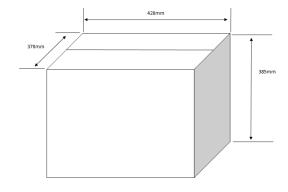
Outbox: 5,000ea (10 x Inbox 500) Dimension: 320 x 380 x 255 mm

Weight: 3.15kg



Outbox: 20,000ea (8 x Inbox 2500) Dimensions: 645 x 360 x 310 mm

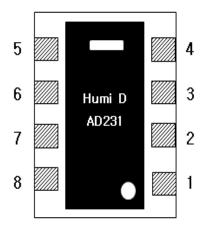
Weight: 8.05kg





2. Interface Specification

2.1 Digital Output (I²C Interface)



Pin-No	Name	Description
1	Alarm_low	Low alarm output
2	Ready	Ready signal (conversion complete output)
3	SDA	I ² C data
4	SCL	I ² C clock
5	V _{CORE}	Core voltage
6	VSS	Ground supply
7	VDD	Supply voltage (2.3-5.5V)
8	Alarm_High	High alarm output

2.1.1 Power Pads (5.VCORE, 6.VSS, 7.VDD)

HumiChip[®] is capable of operating on wide range of power supply voltage from 2.3V to 5.5V.

Recommended supply voltage is either 3.3±0.5V or 5.0±0.5V. Power supply should be connected to VDD (power supply pad 7). VDD and VSS (Ground

pad 6) should be decoupled with a 220nF capacitor.

Important: Vcore must not be connected to VDD, and it must always be connected to an external 100nF capacitor to ground. (see <u>Figure 2.1</u>)

2.1.2 Serial Clock & Data Pads (3. SDA, 4. SCL)

The sensor's data is transferred in and out through the SDA pad while the communication between **HumiChip**® and microcontroller (MCU) is synchronized through the SCL pad.

HumiChip[®] has an internal temperature compensated oscillator that provide time base for all operation, and uses an I²C-compatible communication protocol with support for 20 KHz to

400 KHz bit rates.

External pull-up resistors are required to pull the drive signal high, that can be included in I/O circuits of microcontroller. (see Figure 2.1)

Further information about timing and communication between the sensor and microcontroller is explained in Section 4. Communicating with **HumiChip**®.

2.1.3 Alarm Pads (1. Alarm Low, 8. Alarm High)

The alarm output can be used to monitor whether the sensor reading has exceeded or fallen below pre-programmed values. The alarm can be used to drive an open-drain load connected to VDD, or it can function as a full push-pull driver. If a high voltage application is required, external devices can

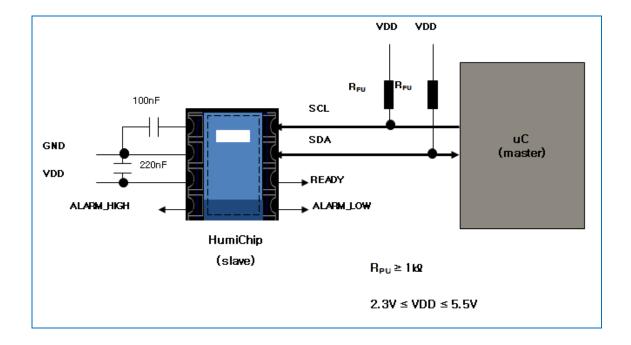
be controlled with the Alarm pins, as demonstrated in Figure 6.2.

The two alarm outputs can be used simultaneously, and these alarms can be used in combination with the I^2C . Further information about Alarm control is explained in **Section 6**.



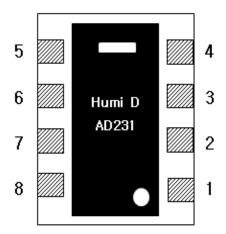
Figure 2.1 Typical Application Circuit (I2C)

- ► VDD and Ground is decoupled by a 220nF capacitor.
- ► Vcore (Not Used) and Ground is decoupled by 100 nF capacitor.
- ► Pull-up resistors should be included between **HumiChip**® and MCU.





2.2 Analog Output (PDM)



Pin-No	Name	Description
1	PDM_T	Temperature PDM
2	PDM_H	Humidity PDM
3	SDA	I2C data (Not Used)
4	SCL	I2C clock (Not Used)
5	VCORE	Core voltage
6	VSS	Ground supply
7	VDD	Supply voltage (2.3-5.5V)
8	Alarm_High	High Alarm output

2.2.1 Power Pads (5.VCORE, 6.VSS, 7.VDD)

HumiChip® is capable of operating on wide range of power supply voltage from 2.3V to 5.5V.

Recommended supply voltage is either 3.3±0.5V or 5.0±0.5V.

Power supply should be connected to VDD (power

supply pad 7). VDD and VSS (Ground pad 6) should be decoupled with a 220nF capacitor.

Important: Vcore must not be connected to VDD, and it must always be connected to an external 100nF capacitor to ground. (see <u>Figure 2.2</u>)

2.2.2 PDM Output Pads (1.PDM_T, 2.PDM_H)

Temperature PDM (Pulse Density Modulation) appears on the PDM_T / Alarm_Low pad (1) and corrected Humidity PDM appears on the PDM_H pad (2).

When pad (1) is selected for Temperature PDM, Alarm_Low function is disabled and only one Alarm

function (Alarm_High: pad 8) is usable.

Note: HumiChip® PDM output is pre-programmed in factory for Humidity and Temperature output mode.

2.2.3 Alarm Pads (8.Alarm_High, 1.Alarm_Low [optional])

As **HumiChip**® PDM is factory set for Humidity and Temperature output mode, only High Alarm output can be used in combination with **HumiChip**® PDM.

If both high and low alarm functions are required, pad 1 and 8 will be programmed at factory to use as

Alarm_Low and Alarm_High respectively with required high and low humidity values. In such case, **HumiChip**® will output corrected humidity PDM only,

See Section 6 for Alarm function.



2.2.4 Serial Clock & Data Pads (3.SDA, 4.SCL)

For **HumiChip**® PDM output, both SDA and SCL

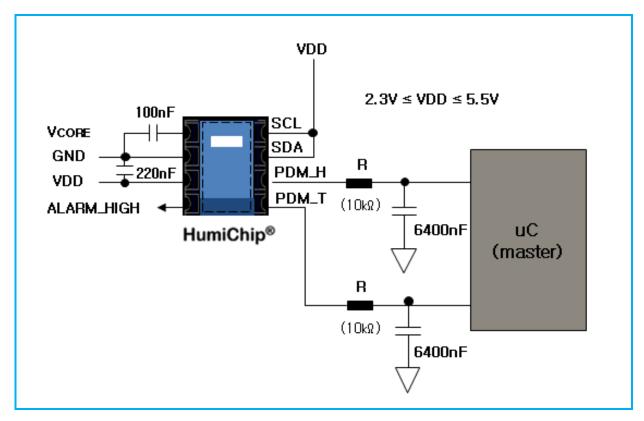
pads are not used and must be connected to VDD.

2.2.5 Typical Circuit Connection

VDD and Ground is decoupled by a 220nF capacitor. Vcore (Not Used) and Ground is also decoupled by a 100nF capacitor. SCL and SDL (not used) are connected to VDD.

Between **HumiChip**[®] and MCU (μ C), **Low Pass Filtering** (see <u>Section 5.2</u> for more information) with 10 k Ω resistors and 6,400nF capacitors is added to create an Analog signal.

Figure 2.2 Typical Application Circuit (PDM)





3. Electrical Specification

3.1 Absolute Maximum Rating

<u>Table 3.1</u>. shows the Absolute Maximum Ratings for HumiChip. Exposure to these extreme condition for extended period may deteriorate the sensor

performance and accelerate aging. Functional operation is not implied at these conditions.

3.2 Electrical Specification and Recommended Operating Conditions

The operating conditions recommended for HumiChip is given in <u>Table 3.2</u> and the electrical specification is shown in <u>Table 3.3</u>.

3.3 Output Pad Drive Strength

Output pad drive strength at different supply voltages and operating temperatures are shown in **Table 3.4** and **Table 3.5**.

3.4 ESD/Latch-Up-Protection

All external module pins have an ESD protection of up to 4000V and a latch-up protection of $\pm 100 \, \text{mA}$ or (up to $\pm 400 \, \text{mA}$) relative to VSS/VSSA. The internal module pin VCORE has ESD protection

of up to 2000V. The ESD test follows the Human Body Model with 1.5kOhm/100 $\rm pF$ based on MIL 883, Method 3015.7.

Table 3.1 Absolute Maximum Rating

PARAMETER	SYMBOL	MIN	MAX	Unit
Supply Voltage (V _{DD})	V_{DD}	-0.3	6.0	V
Supply Voltage at I/O pads	Vio	-0.3	VDD+0.3	٧
Storage Temperature Range	T _{STOR}	-55	150	°C
Junction Temperature	T_{j}	-55	150	°C

<u>Table 3.2</u> Recommended Operating Conditions

PARAMETER	SYMBOL	MIN	TYP	MAX	UNIT
Supply Voltage to Gnd	V _{SUPPLY}	2.3		5.5	V
Ambient Temperature Range	T _{AMB}	-40		125	°C
External Capacitance between V _{DD} pin and Gnd	C _{VSUPPLY}	100	220	470	nF
External Capacitance between Vcore and Gnd - Sleep	C _{VCORE_SM}	10		110	nF
External Capacitance between Vcore and Gnd - Update	C _{VCORE_UM}	90		330	nF
Pull-up on SDA and SCL	R _{PU}	1	2.2		kΩ



<u>Table 3.3</u> Electrical Characteristics Specifications

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
		SUPPLY				
Supply Current (varies with update rate and output mode)	I _{DD}	At maximum update rate		750	1100	μA
Extra Current with PDM enabled	I _{PDM}	At maximum update rate		150		μA
Sleep Mode Current	1.	-40 to 85°C		0.6	1	μA
Sleep Mode Current	I _{sleep}	-40 to 125°C		1	3	μA
		PDM Output				
Voltage Range	V _{PDM_Range}	3V±10%, 3.3V±10%, 5V±10%	10		90	%V _{SUPPLY}
PDM Frequency	f _{PDM}			f _{SYS} /8		KHz
Filter Settling Time ¹	t _{SETT}	0% to 90% LPFilter 10kΩ/400nF			9.2	ms
Ripple ¹	V_{RIPP}	0% to 90% LPFilter 10kΩ/400nF			1.0	mV/V
PDM Additional Error (Including Ratiometricity Error)	E _{PDM}	-40 to 125°C		0.1	0.5	%
		DIGITAL I/O				
Voltage Output Level Low	V _{OL}			0	0.2	V _{SUPPLY}
Voltage Output Level High	V _{OH}		0.8	1		V _{SUPPLY}
Voltage Input Level Low	V _{IL}			0	0.2	V _{SUPPLY}
Voltage Input Level High	V _{IH}		0.8	1		V _{SUPPLY}
TOTAL SYSTEM						
Start-Up-Time ' Power-on (POR) to data ready	t _{STA}	At nominal frequency; fastest and slowest settings	4.25		55	ms
Update Rate(Update Mode)	t _{RESP_UP}	Fastest and slowest settings	0.70		165	ms
Response Time(Sleep Mode)	t _{RESP_SL}	Fastest and slowest settings	1.25		45	ms



Table 3.4 Output High Drive Strength

Output High Drive Strength (mA)						
V (V)	-40°C		25°C		125°C	
V _{SUPPLY} (V)	Min	Тур	Min	Тур	Min	Тур
2.3	3.8	6.2	3.3	5.1	2.8	4.2
2.7	7.2	10.5	5.9	8.4	4.7	6.6
3.3	12.1	16.6	9.6	12.9	7.4	10.0
5.5	20.0	20.0	20.0	20.0	20.0	20.0

Table 3.5 Output Low Drive Strength

Output Low Drive Strength (mA)						
V (V)	-40)°C	25	°C	125	5°C
V _{SUPPLY} (V)	Min	Тур	Min	Тур	Min	Тур
2.3	10.8	16.0	8.8	12.6	6.9	9.5
2.7	20.0	20.0	16.0	20.0	11.7	14.9
3.3	20.0	20.0	20.0	20.0	18.2	20.0
5.5	20.0	20.0	20.0	20.0	20.0	20.0



4. Communicating with HumiChip®

4.1 Power-On Sequence

On system power-on reset (POR), the **HumiChip**® wakes as an I²C device regardless of the output protocol programmed in EEPROM. After power-on reset, it enters the command window. It then waits for a Start_CM command for 10 ms if Fast Startup bit is not set in EEPROM (Factory Setting) or for 3 ms if fast startup bit is set in EEPROM (see **Figure 4.1.2**). If the **HumiChip**® receives the Start_CM command during the command window, it enters and remains in Command Mode.

Command Mode is primarily used for initializing $\mathbf{HumiChip}^{\mathbb{B}}$.

If during the power-on sequence, the command window expires without receiving a Start_CM or if the part receives a Start_NOM command in Command Mode, the device will immediately assume its programmed output mode and will perform one complete measurement cycle

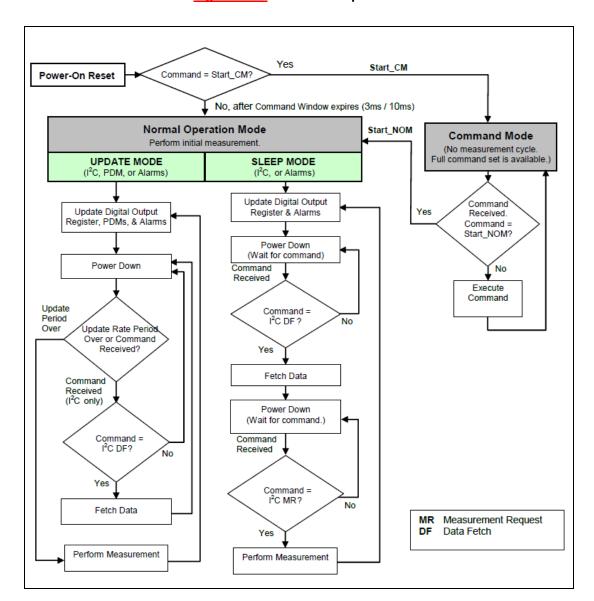


Figure 4.1.1 General Operation



Figure 4.1.2 Power-On Sequence with Fast Start-up Bit Set in EEPROM

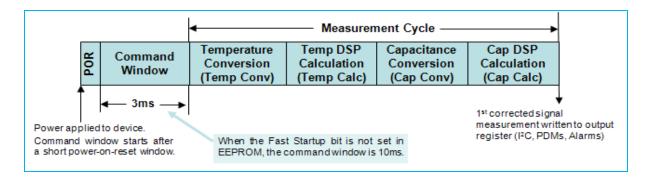
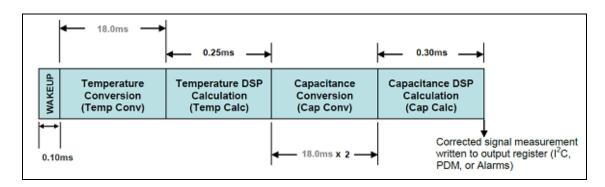


Figure 4.1.3 Measurement Cycle Timing



4.2 I²C Features and Timing

The HumiChip[®] uses I²C-compatible communication protocol with support for 20kHz to 400kHz bit rates. The I²C slave address (0x00 to 0x7F) is selected by the Device_ID bits in the Cust_Config EEPROM word (see <u>Table 6.1</u> for bit assignments).

See <u>Figure 4.2</u> for I²C Timing Diagram and <u>Table</u> <u>4.1</u> for definitions of the parameters shown in the diagram.

diagram.

Note: Detailed Timing Chart and Reference

Programming Code are available upon request.

Figure 4.2 I²C Timing Diagram

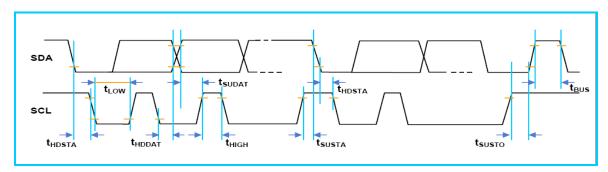




Table 4.1 I²C Parameters

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS
SCL clock frequency	f _{SCL}	20		400	kHz
Start condition hold time relative to SCL edge	t _{HDSTA}	0.1			μS
Minimum SCL clock low width ¹	t _{LOW}	0.6			μs
Minimum SCL clock high width ¹	t _{HIGH}	0.6			μS
Start condition setup time relative to SCL edge	tsusta	0.1			μs
Data hold time on SDA relative to SCL edge	t _{HDDAT}	0		0.5	μs
Data setup time on SDA relative to SCL edge	t _{SUDAT}	0.1			μS
Stop condition setup time on SCL	tsusто	0.1			μS
Bus free time between stop condition and start condition	t _{BUS}	1			μS

^{1.} Combined low and high widths must equal or exceed minimum SCL period

4.3 Measurement Modes

The **HumiChip**[®] can be programmed to operate in either Sleep Mode or Update Mode. The measurement mode is selected with the Measurement_Mode bit in the **HumiChip**[®] Config

Register word. In Sleep Mode, the part waits for commands from the master before taking measurements (see **section 4.3.2**).

4.3.1 Data Fetch in Update Mode

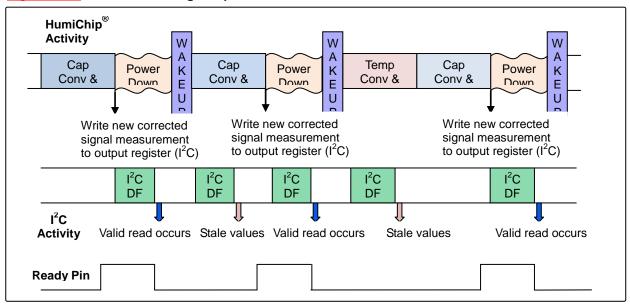
In Update Mode, I₂C is used to fetch data from the digital output register using a Data Fetch (DF) command.

Detecting when data is ready to be fetched can be handled either by polling or by monitoring the Ready pin (see section 4.8 for details on the Ready pin). The status bits of a DF tell whether or not the data is valid or stale (see **Table 4.2**

regarding the status bits). As shown in <u>Figure 4.3.1</u> after a measurement cycle is complete, valid data can be fetched. If the next data fetch is performed too early, the data will be the same as the previous fetch with stale status bits. As shown in <u>Figure 4.3.1</u>, a rise on the Ready pin can also be used to tell when valid data is ready to be fetched.



Figure 4.3.1 I²C Data Fetching in Update Mode



4.3.2 Data Fetch in Sleep Mode

In Sleep Mode, the **HumiChip**® **core** will only perform conversions when **HumiChip**® receives a Measurement Request command (MR); otherwise, the **HumiChip**® is always powered down. Measurement Request commands can only be sent using I₂C, so Sleep Mode is **not available for PDM**. The Alarms can be used in Sleep Mode but only in combination with I₂C.

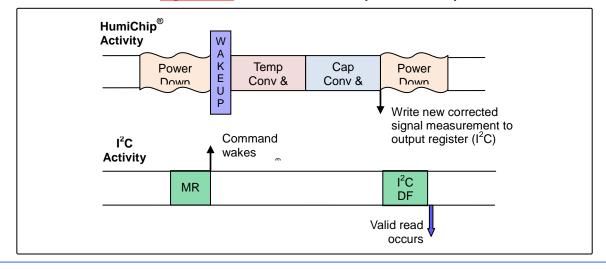
Note: Sleep Mode power consumption is significantly lower than Update Mode power consumption (see <u>Table 3.3</u> for exact values).

Figure 4.3.2 shows the measurement and communication sequence for Sleep Mode. The master sends an MR command to wake the

HumiChip® from power down. After **HumiChip**® wakes up, a measurement cycle is performed consisting of both a temperature and a capacitance conversion followed by the **HumiChip® Core** correction calculations.

At the end of a measurement cycle, the digital output register and Alarms will be updated before powering down. An I²C data fetch (DF) is performed during the power-down period to fetch the data from the output register. In I²C the user can send another MR to start a new measurement cycle without fetching the previous data. After the data has been fetched, the **HumiChip**® remains powered down until the master sends an MR command.

Figure 4.3.2 Measurement Sequence in Sleep Mode





HumiChip® Activity W Α Κ Temp Cap Power Power Е Conv & Calc Conv & Calc Down Down U Ρ Write new corrected signal measurement to output register (I²C) Command wakes I²C HumiChip[®] Activity MR DF DF Stale values Valid read occurs Ready Pin

Figure 4.3.3 I²C Data Fetching in Sleep Mode

In Sleep Mode, I2C are used to request a measurement with a MR command and to fetch data from the digital output register using a Data Fetch (DF) command (see **section 4.7** for details on the MR command).

Detecting when data is ready to be fetched can be handled either by polling or by monitoring the Ready pin (see **section 4.8** for details on the Ready pin). The status bits of a DF tell whether the data is valid or stale (see **section 4.4** regarding the status bits), but polling for the result must not be done before the time required for conversion has elapsed. As shown in Figure 4.3.3 after a measurement cycle is complete, valid data can be

fetched. If the next data fetch is performed too early, the data will be the same as the previous fetch with stale status bits. As shown in <u>Figure 4.3.3</u> a rise on the Ready pin can also be used to tell when valid data is ready to be fetched.

Note: There is an 18us period when the measurement cycle completes that must have the bus unlocked. So wait for the measurement cycle to complete prior to reading the I2C bus. This can be determined using either the ready pin or by waiting a fixed amount of time as specified in Figure 4.1.3. Or use an I2C frequency of 60kHz or greater.

4.4 Status Bits

Status bits (the two MSBs of the fetched high data byte, see <u>Table 4.2</u>) are provided in I²C but not in

PDM. The status bits are used to indicate the current state of the fetched data.

Table 4.2 Status Bits

Status Bits(I ² C)	PDM Output	Definition
00в	Clipped normal output	Valid data: Data that has not been fetched since the last measurement cycle.
01в	Not applicable	Stale data: Data that has already been fetched since the last measurement cycle.
10в	Not applicable	Command Mode: The HumiChip ® is in Command Mode.
11в	Not used	Not used



4.5 I²C Commands

As detailed in <u>Table 4.3</u>, there are two types of commands which allow the user to interface with

the **HumiChip**[®] in the I²C.

Table 4.3 I²C Command Bits

Туре	Description	Communication Supported	Reference Sections
Data Fetch (DF)	Used to fetch data in any digital mode	I ² C	Section 4.6
Measurement Request (MR)	rement Request (MR) Used to start measurements in Sleep Mod		Section 4.7

4.6 Data Fetch (DF)

The Data Fetch (DF) command is used to fetch data in any digital output mode.

An I^2C Data Fetch command starts with the 7-bit slave address and the 8^{th} bit = 1 (READ).

The **HumiChip**[®] as the slave sends an acknowledgement (ACK) indicating success.

The number of data bytes returned by the **HumiChip**® is determined by when the master sends the NACK and stop condition. Figure 4.3 shows examples of fetching two, three and four bytes respectively.

The full 14 bits of humidity data are fetched in the first two bytes. The MSBs of the first byte are the status bits.

If temperature data is needed, additional temperature bytes can be fetched. In Figure 4.3, the three-byte data fetch returns 1 byte of temperature data (8-bit accuracy) after the humidity data. A fourth byte can be fetched where the six MSBs of the fetched byte are the six LSBs of a 14-bit temperature measurement. The last two bits of the fourth byte are undetermined and should be masked off in the application.

4.7 Measurement Request (MR)

A measurement request (MR) is a Sleep-Modeonly command sent by the master to wake up the $\mathbf{HumiChip}^{\otimes}$ and start a new measurement cycle in $\mathbf{I}^2\mathbf{C}$.

The I²C MR is used to wake up the device in Sleep Mode and start a complete measurement cycle starting with a temperature measurement, followed by a humidity measurement, and then the results can be fetched by master with I²C.

As shown in Figure 4.4, the communication

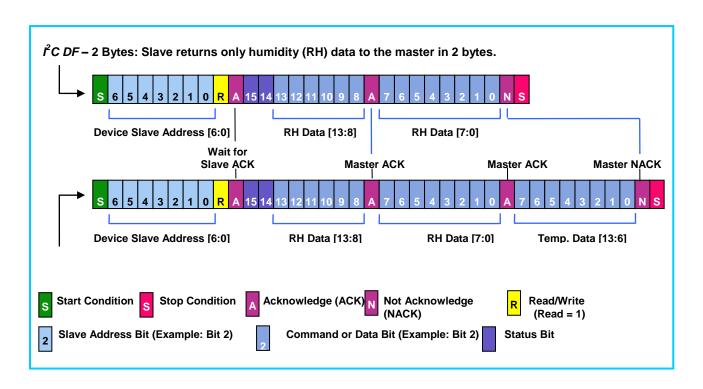
contains only the slave address and the WRITE bit (0) sent by the master.

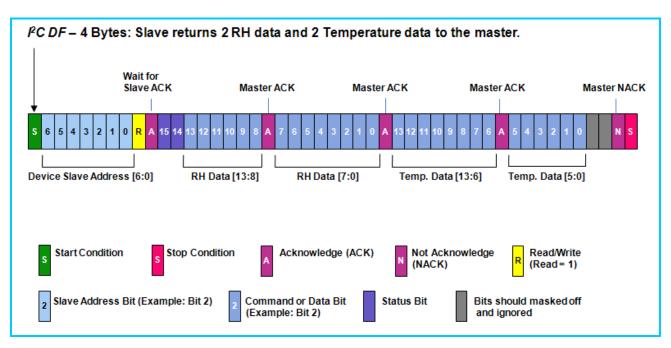
After the **HumiChip**[®] responds with the slave ACK, the master creates a stop condition.

Note: The I²C MR function can also be accomplished by sending "don't care" data after the address instead of immediately sending a stop bit.



Figure 4.3 I²C Measurement Packet Reads

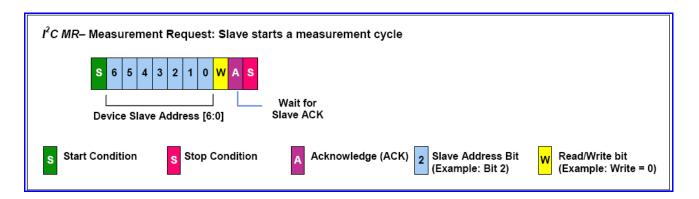




Humidity & Temperature Conversion Formula			
Humidity Output (%RH) (RH_High [5:0] x 256 + RH_Low [7:0]) / 2 ¹⁴ x 100			
Temperature Output (°C) (Temp_High [7:0] x 64 + Temp_Low [7:2] / 4) / 2 ¹⁴ x 165 - 4			



Figure 4.4 I²C Measurement Request



4.8 Ready Pin

A rise on the Ready pin indicates that new data is ready to be fetched from the I^2C interface. The Ready pin stays high until a Data Fetch (DF) command is sent; it stays high even if additional measurements are performed before the DF.

The Ready pin's output driver type is selectable as either full push-pull or open drain using the **Note:** If two high alarms or two low alarms are

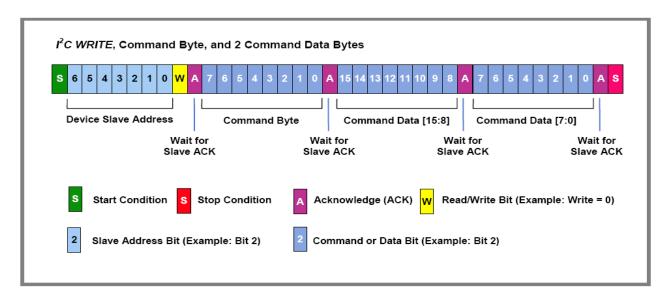
Ready_Open_Drain bit in EEPROM word Cust_Config (see <u>Table 6.1</u> for bit assignments and settings). Point-to-point communication most likely uses the full push-pull driver. If an application requires interfacing to multiple parts, then the open drain option can allow for just one wire and one pull-up resistor to connect all the parts in a bus format.

4.9 Command Mode

Command Mode commands are only supported for the I²C protocol. As shown in Figure 4.5, commands are 4-byte packets with the first byte being a 7-bit

slave address followed by 0 for write. The second byte is the command byte and the last two bytes form a 16-bit data field.

Figure 4.5 I²C Command Format





4.10 Command Encodings

Table 4.4 describes all the commands that are

offered in Command Mode.

Note: Only the commands listed in <u>Table 4.4</u> are valid. Other encodings might cause unpredictable results. If data is not needed for the command,

zeros must be supplied as data to complete the 4byte packet.

<u>Table 4.4</u> Command List and Encodings

Command Byte 8 Command Bits (Hex)	Third and Fourth Bytes 16 Data Bits(Hex)	Description	Response Time
0x16 to 0x1F	0x0000	EEPROM Read of addresses 0x16 to 0x1F After this command has been sent and executed, a data fetch must be performed.	100µs
0x56 to 0x5F	0xYYYY (Y = data)	Write to EEPROM addresses 0x16 to 0x1F The 2 bytes of data sent will be written to the address specified in the 6 LSBs of the command byte.	12ms
0x80	0x0000	Start_NOM Ends Command Mode and transitions to Normal Operation Mode.	
0xA0	0x0000	Start_CM Start Command Mode: used to enter the command interpreting mode. Start_CM is only valid during the power-on command window.	100µs

4.11 Command Response and Data Fetch

After a command has been sent and the execution time defined in <u>Table 4.4</u> has expired, an I²C Data Fetch (DF) can be performed to fetch the response. As shown in <u>Figure 4.6</u>, after the slave address has been sent, the first byte fetched is the response byte.

The upper two status bits will always be $10_{\rm B}$ to represent Command Mode. The lower two bits are the response bits. <u>Table 4.5</u> describes the different responses that can be fetched. To determine if a command has finished executing, poll the part until a Busy response is no longer received. The middle four bits of the response byte are command diagnostic bits where each bit represents a different diagnostic (see <u>Table 4.6</u>).

Note: Regardless of what the response bits are, one or more of the diagnostic bits may be set indicating an error occurred during the execution of the command.

Note: Only one command can be executed at a

time. After a command is sent another command must not be sent until the execution time of the first command defined in **Table 4.4** has expired.

For all commands except EEPROM Read, the data fetch should be terminated after the response byte is read. If the command was an EEPROM Read, then the user will fetch two more bytes as shown in Figure 4.6, example 3. If a Corrected EEPROM Error diagnostic was flagged after an EEPROM read, the user has the option to write this data back to attempt to fix the error. Instead of polling to determine if a command has finished executing, the user can use the Ready pin. In this case, wait for the Ready pin to rise, which indicates that the command has executed. Then a data fetch can be performed to get the response and data (see Figure 4.6)



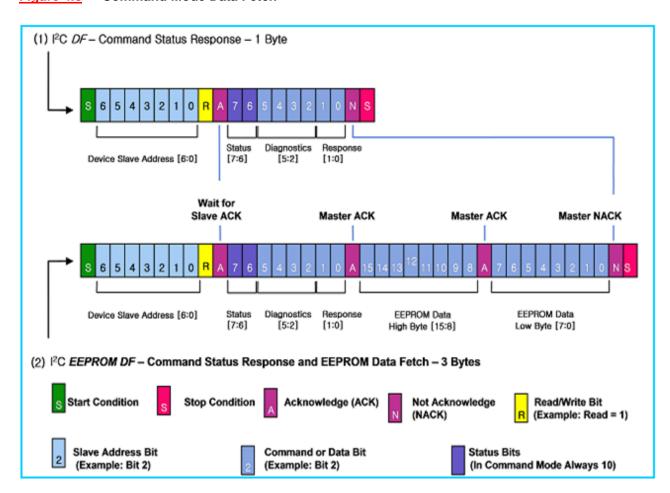
Table 4.5 Response Bits

Encoding	Name	Description
00 _B	Busy	The command is busy executing.
01 _B	Positive Acknowledge	The command executed successfully.
10 _B	Negative Acknowledge	The command was not recognized or an EEPROM write was attempted while the EEPROM was locked.

Table 4.6 Command Diagnostic Bits

Bit Position	Name	Description
2	Corrected EEPROM Error	A corrected EEPROM error occurred in execution of the last command.
3	Uncorrectable EEPROM Error	An uncorrectable EEPROM error occurred in execution of the last command.
4	RAM Parity Error	A RAM parity error occurred during a microcontroller instruction in the execution of the last command.
5	Configuration Error	An EEPROM or RAM parity error occurred in the initial loading of the configuration registers.

Figure 4.6 Command Mode Data Fetch





4.12 EEPROM

The EEPROM array contains the calibration coefficients for gain and offset, etc., and the configuration bits for the analog front end, output modes, measurement modes, etc. The **HumiChip**® EEPROM is arranged as 10 16-bit words (see Table 4.7).

See section **4.9 Command Mode** for instructions on reading and writing to the EEPROM in Command Mode via the I²C interface. When programming the EEPROM, an internal charge pump voltage is used; therefore a high voltage supply is not needed.

Table 4.7 EEPROM Word Assignments

EEPROM Word	Bit Range	IC Default	Name	Description and Notes	
16 _{HEX}	13:0	0x3FFF	PDM_Clip_High	PDM high clipping limit	
17 _{HEX}	13:0	0x0000	PDM_Clip_Low	PDM low clipping limit	
18 _{HEX}	13:0	0x3FFF	Alarm_High_On	High alarm on trip point	
19 _{HEX}	13:0	0x3FFF	Alarm_High_Off	High alarm off trip point	
1A _{HEX}	13:0	0x0000	Alarm_Low_On	Low alarm on trip point	
1B _{HEX}	13:0	0x0000	Alarm_Low_Off	Low alarm off trip point	
1C _{HEX}	15:0	0x0028	Cust_Config	Customer Configuration (see <u>Table 6.1</u>)	
1D _{HEX}	15:0	0x0000	Reserved	Reserved Word: Do Not Change ; must leave at factory settings	
1E _{HEX}	15:0	0x0000	Cust_ID2	Customer ID byte 2: For use by customer	
1F _{HEX}	15:0	0x0000	Cust_ID3	Customer ID byte 3: For use by customer	



5. Converting PDM to Analog Signal

5.1 PDM (Pulse Density Modulation)

Both corrected humidity and temperature are available in PDM output. Humidity PDM appears on PDM_H (2) pad and Temperature PDM appears on the PDM_T (1) pad.

The PDM frequency is 231.25kH±15% (i.e., the oscillator frequency 1.85\mu±15% divided by 8). Both PDMs output 14-bit values for Humidity and

Temperature.

In PDM Mode, **HumiChip**® is programmed to Update Mode. Every time a conversion cycle has finished, the PDM will begin outputting the new value.

See <u>Figure 5.1</u> for PDM Timing Diagram.

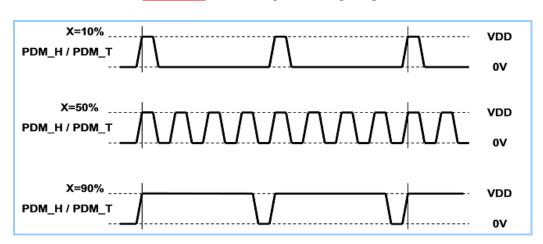


Figure 5.1 PDM Signal Timing Diagram

5.2 Low Pass Filtering

An analog output value is created by low-pass filtering the PDM output; a simple first-order RC filter will work in this application. Select the time constant of the filter based on the requirements for setting time and/or peak-to-peak ripple.

 $\label{eq:local_local_local} \mbox{Important: The resistor of the RC filter must be} \\ \geq 10 k \Omega.$

Table 5.1 Low Pass Filter Example for R=10kΩ

Filter Canaitanes (nF)	PDI	Desired Analog		
Filter Capcitance (nF)	Vpp Ripple (mV/V)	0 to 90% settling time (ms)	Output Resolution	
100	4.3	2.3	8	
400	1.0	9.2	10	
1600	0.3	36.8	12	
6400	0.1	147.2	14	



For different (higher) resistor, the normalized ripple VPP(mV/V) can be calculated as

$$VPP(mV / V) = 4324 / [R(k\Omega) * C(nF)]$$

Or the setting time t_{SETT} for a 0% to 90% setting can be calculated as

$$t_{SETT}$$
 (ms) = 0.0023 * R(k Ω) * C(nF)

5.3 Analog Output Characteristics

5.3.1 Polynomial Equation Humidity

5.3.2 Polynomial Equation Temperature

$$PDM_T[mV] = ((T[^{\circ}C] / 165) + 0.2424) * VDD[mV]$$



6. Alarm Function (Optional)

6.1 Alarm Output

The alarm output can be used to monitor whether Humidity reading has exceeded or fallen below preprogrammed values. The alarm can be used to drive an open-drain load connected to VDD as shown in Figure 6.3 or it can function as a full push-pull driver.

If a high voltage application is required, external devices can be controlled with the Alarm pads, as demonstrated in <u>Figure 6.1</u> and <u>Figure 6.2</u>.

In standard **HumiChip®** PDM mode, only the High Alarm can be used.

6.2 Alarm Registers

Four registers are associated with the alarm functions: Alarm_High_On, Alarm_High_Off, Alarm_Low_On, and Alarm_Low_Off (see <u>Table 4.7</u>). Each of these four registers is a 14-bit value that determines where the alarms turn on or off. The two high alarm registers form the output with hysteresis for the Alarm_High pin, and the two low alarm registers form the output with hysteresis for

the Alarm_Low pin. Each of the two alarm pins can be configured independently using Alarm_Low_Cfg and Alarm_High_Cfg located in EEPROM word Cust_Config (see <u>Table 6.1</u> for bit assignments).

Note: If two high alarms or two low alarms are needed, see **section 6.5 Alarm Polarity**.

6.3 Alarm Operation

As shown in Figure 6.4 the Alarm_High_On register determines where the high alarm trip point is and the Alarm_High_Off register determines where the high alarm turns off if the high alarm has been activated. The high alarm hysteresis value is equal to Alarm_High_On – Alarm_High_Off. The same is

true for the low alarm where Alarm_Low_On is the low alarm trip point with Alarm_Low_Off determining the alarm shut off point. The low alarm hysteresis value is equal to Alarm_Low_Off – Alarm_Low_On. Figure 6.5 shows output operation flowcharts for both the Alarm_High and Alarm_Low pins.

6.4 Alarm Output Configuration

The user can select the output driver configuration for each alarm using the Output Configuration bit in the Alarm_High_Cfg and Alarm_Low_Cfg registers in EEPROM word Cust_Config (see <u>Table 6.1</u> for bit assignments). For applications, such as interfacing with a microcontroller or controlling an external device, select the full push-pull driver for the alarm output type. For an application that directly drives a

load connected to VDD, the typical selection is the open-drain output type. An advantage of making an alarm output open drain is that in a system with multiple devices, the alarm outputs of each **HumiChip**® can be connected together with a single pull-up resistance so that one can detect an alarm on any device with a single wire.

6.5 Alarm Polarity

For both alarm pins, the polarity of the alarm output is selected using the Alarm Polarity bit in the Alarm_High_Cfg and Alarm_Low_Cfg registers in EEPROM word Cust_Config (see <u>Table 6.1</u> for bit assignments). Another feature of the polarity bits is the ability to create two high alarms or two low alarms. For example, with applications requiring two high alarms, flip the polarity bit of the Alarm_Low pin, and it will act as a high alarm.

However, in this case, the effect of the alarm low registers is also changed: the Alarm_Low_On

register would act like the Alarm_High_Off register and the Alarm_Low_Off register would act like the Alarm_High_On register. The same can be done to achieve two low alarms: the Alarm_High pin would have the polarity bit flipped, and the two Alarm_High registers would have opposite meanings.



Figure 6.1 Bang-Bang Humidity Control (High Voltage Application)

HumiChip® PDM: 1 Alarms / Humidity Output (Optional)

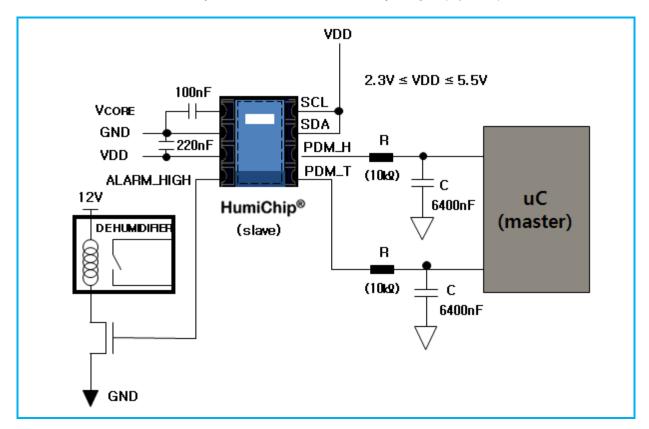


Figure 6.2 Bang-Bang Humidity Control (High Voltage Application)

HumiChip® I2C: 2 Alarms / Humidity Output (Optional)

HumiChip® also can be directly installed to a device without MCU interface when only a switch on/off function is required at desired humidity level. (*e.g.* Bathroom Vent Fan, Humidifiers, Dehumidifiers)

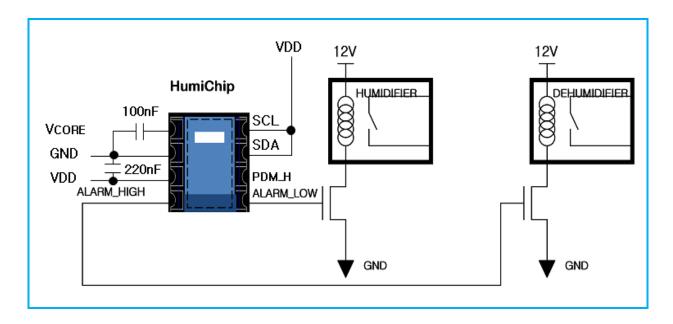




Figure 6.3 LED control with Alarm function

HumiChip® PDM: 1 Alarms / Humidity Output (Optional)

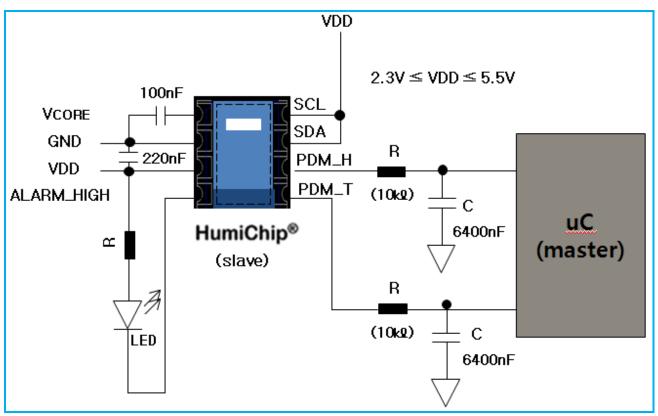
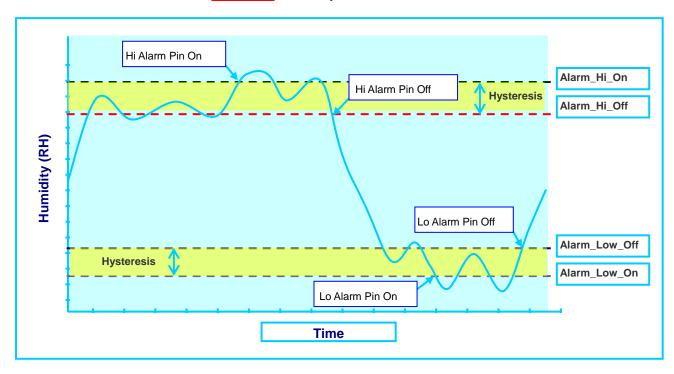


Figure 6.4 Example of Alarm Function





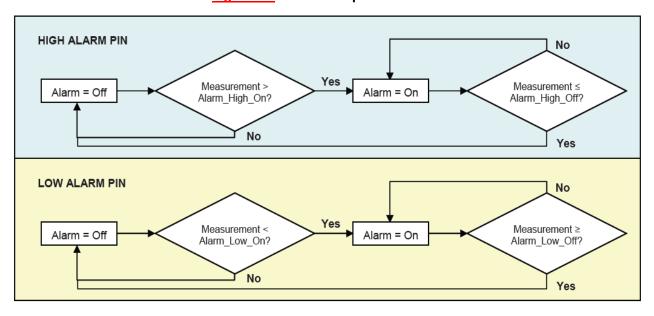


Figure 6.5 Alarm Output Flow Chart

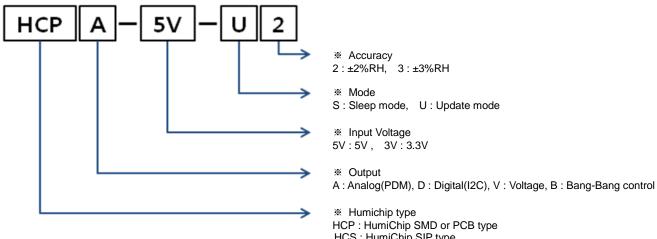
Table 6.1 Cust_Config Bit Assignments

Bit Range	IC Default	Name	Description and Notes		
6:0	0101000	Device_ID	I ² C slave address		
8:7	00	Alarm_Low_Cfg	Configure the Alarm_Low output pin: Bits Description		
			Alarm Polarity: 7 0 = Active High 1 = Active Low		
			Output Configuration: 8 0 = Full push-pull 1 = Open drain		
10:9	00	Alarm_High_Cfg	Configure the Alarm_High output pin:		
			Bits Description		
			Alarm Polarity: 9 0 = Active High 1 = Active Low		
			Output Configuration: 10 0 = Full push-pull 1 = Open drain		
*12	0	Ready_Open_Drain	Ready pin is 0 = Full push-pull 1 = Open drain		
*13	0	Fast_Startup	Sets the Command Window length: 0 = 10 ms Command Window 1 = 3 ms Command Window		
15:14	00	Reserved	Do Not Change – must leave at factory settings		

^{*} Only applies to I2C output



Table 7.1 HumiChip Part Number List



HCP: HumiChip SMD or PCB type HCS: HumiChip SIP type

Items	Series	Output	Operating Voltage(V)	Mode	Accuracy(%RH)	Part Number
			5	Update	±2	HCPA-5V-U2
Humi A	НСР	PDM	5	Update	±3	HCPA-5V-U3
	(SMD)	(<u>A</u> nalog)	3.3	Update	±2	HCPA-3V-U2
			3.3	Update	±3	HCPA-3V-U3
			5	Update	±2	HCPD-5V-U2
Humi D			5	Update	±3	HCPD-5V-U3
			3.3	Update	±2	HCPD-3V-U2
	НСР	I2C	3.3	Update	±3	HCPD-3V-U3
	(SMD)	(<u>D</u> igital)	5	Sleep	±2	HCPD-5V-S2
			5	Sleep	±3	HCPD-5V-S3
			3.3	Sleep	±2	HCPD-3V-S2
			3.3	Sleep	±3	HCPD-3V-S3

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